PCN Number:	20	210722000.1		PCN Date	August 03, 2021		
Title: Oua			AB as an additional wafer fab site option for select LBC5 devices				
Customer Con		PCN Manager		Dept:	Quality Services		
				ted Sampl			
Proposed 1st Ship Date:		Nov. 3, 2021		Availability:			
Change Type:							
Assembly 9	Site		y Process	A	ssembly Materials		
Design		Electrical Specification			Mechanical Specification		
Test Site			Shipping/Labeling		est Process		
	Wafer Bump Site		Wafer Bump Material		/afer Bump Process		
			b Materials		lafer Fab Process		
			ber change				
Description of		PC	N Details				
•		announce the qualification of CFAE sted in the product affected section					
Current	Fab	Wafer	Additional	Fab	Wafer		
Fab Site	Process	Diameter	Fab Site	Process	Diameter		
DP1DM5	LBC5	200 mm	CFAB	LBC5	200 mm		
Anticipated in							
Vone	pact on For	m, Fit, Function	n, Quality or Rel	iability (po	ositive / negative):		
			n, Quality or Rel		ositive / negative):		
					ositive / negative):		
Changes to pr	oduct identi	fication resulti		V:			
Changes to pr	oduct identi	fication resulti	ng from this PCI	N: cry Code (2			
Changes to pr Current: Chip Site DP1DM5	oduct identi	fication resulti te Origin Code (20L)	ng from this PCI Chip Site Count	N: cry Code (2	1L) Chip Site City		
Changes to pr Current: Chip Site DP1DM5	Chip Si	te Origin Code (20L) DM5 te Origin Code	ng from this PCI Chip Site Count	N: cry Code (2	1L) Chip Site City Dallas		
Changes to pr Current: Chip Site DP1DM5 New: Chip Site	Chip Si	fication resulti te Origin Code (20L) DM5	ng from this PCI Chip Site Count	N: cry Code (2	1L) Chip Site City Dallas 1L) Chip Site City		
Changes to pr Current: Chip Site DP1DM5 New:	Chip Si	te Origin Code (20L) DM5	Chip Site Count	N: cry Code (2	1L) Chip Site City Dallas		
Current: Chip Site DP1DM5 New: Chip Site CFAB Sample product TEXAS INSTRUMENT	Chip Si Chip Si	te Origin Code (20L) DM5	Chip Site Count Chip Site Count Chip Site Count CH Oduct label)	try Code (2 N	1L) Chip Site City Dallas 1L) Chip Site City Chengdu		
Changes to pr Current: Chip Site DP1DM5 New: Chip Site CFAB Sample product	Chip Si Chip Si t shipping labe	te Origin Code (20L) DM5 te Origin Code (20L) CU3 el (not actual pro	Chip Site Count Chip Site Count Chip Site Count CH Oduct label) (1P) \$N (Q) 20 (31T) L	74LS07NS	1L) Chip Site City Dallas 1L) Chip Site City Chengdu 6R 9) 0336		

SN65HVD1794P

SN65HVD1794DR

Product Affected:
SN65HVD1794D

Qualification Report

Approve Date 29-Jun-2021

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: SN65HVD1794D	QBS Package Reference: TAS5613APHD
	ECD_LIDM (All =!==)	4000 1/		<u>1A35613APHD</u>
-	ESD - HBM (All pins)	4000 V	1/3/0	-
AC	Autoclave 121C	96 Hours	-	3/231/0
CDM	ESD - CDM	1500 V	1/3/0	-
ED	Electrical Characterization	Per Datasheet Parameters	1/Pass	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	3/231/0
HBM	ESD - HBM (All pins)	4000 V	1/3/0	-
HBM	ESD - HBM (Bus Pins Only)	16000 V	1/3/0	-
HTOL	Life Test, 125C	1000 Hours	1/77/0	-
HTOL	Life Test, 155C	240 Hours	-	3/231/0
HTSL	High Temp. Storage Bake, 170C	420 Hours	-	3/230/0
LU	Latch-up	(Per JESD78)	1/6/0	-
TC	Temperature Cycle, -65/150C	500 Cycles	-	3/231/0

- QBS: Qual By Similarity
- Qual Device SN65HVD1794D is qualified at LEVEL1-260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free (SMT) and Green

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